

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/657,350	BOYKIN ET AL.	
Examiner	Art Unit	
Sin J. Lee	1752	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST TEXT Search (All search History printout)	2-5 -06	SJL
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